IN THE CLAIMS

Please amend the claims as follows:

- 1. (Currently Amended) A negative radiation-sensitive resin composition comprising:
- (A) a polymer containing structural units represented by the following formula (1) and/or the following formula (2):

$$\begin{array}{c} R_1 \\ CH_2 - C \\ O = C \\ NH \\ R_2 \\ R_3 \\ M \end{array} \tag{1}$$

$$\begin{array}{c} R_1 \\ CH_2 - C \\ O = C \\ O \\ R_2 \\ O \end{array} \tag{2}$$

wherein R_1 is a hydrogen atom or a methyl group, R_2 is $-(CH_2)_n$ -, n is an integer of 0 to 3, R_3 is an alkyl group of 1 to 4 carbon atoms, and m is an integer of 0 to 4,

- (B) a compound having at least one ethylenically unsaturated double bond, and
- (C) a radiation-sensitive radical polymerization initiator <u>which is at least one</u> compound selected from acylphosphine oxides, 2,2-dimethoxyl-1,2-diphenylethane-1-one, benzyl dimethyl ketal, benzyl-β-methoxyethyl acetal, 1-phenyl-1,2-propanedione-2-(o-

ethoxycarbonyl) oxime and 2,2'-bis(2,4-dichlorophenyl)-4,5,4',5'-tetrapheyl-1-2'-

bisimidazole.

Claims 2-3: (Canceled).

4. (Original) The negative radiation-sensitive resin composition as claimed in claim

1, wherein the component (B) is contained in an amount of 30 to 80 parts by weight based on

100 parts by weight of the component (A).

5. (Original) The negative radiation-sensitive resin composition as claimed in claim

1, wherein the component (C) is contained in an amount of 15 to 30 parts by weight based on

100 parts by weight of the component (A).

6. (Original) The negative radiation-sensitive resin composition as claimed in claim

1, which further comprises an organic solvent (D).

7. (Original) A transfer film having a resin film composed of the negative radiation-

sensitive resin composition of claim 1 on a support film.

8. (Original) The transfer film as claimed in claim 7, wherein the resin film has a

film thickness of 5 to 200 μm .

9. (Original) A process for producing a plated shaped article, comprising:

(1) a step of forming a resin film composed of the negative radiation-sensitive resin

composition of claim 1 on a wafer having a barrier metal layer,

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- (2) a step of exposing the resin film and then developing the resin film to form a pattern,
- (3) a step of depositing an electrode material by electroplating using the pattern as a mold, and
- (4) a step of stripping the remaining resin film and then removing the barrier metal by etching.
- 10. (New) A process for producing a plated shaped article by the use of the resin composition of Claim 1.
- 11. (New) A process for producing a bump by the use of the resin composition of Claim 1.
- 12. (New) A process for producing the composition of Claim 1, comprising combining (A), (B) and (C).
- 13. (New) The negative radiation-sensitive resin composition as claimed in claim 1, wherein (C) comprises an acylphosphine oxide.
- 14. (New) The negative radiation-sensitive resin composition as claimed in claim 1, wherein (C) comprises 2,2-dimethoxyl-1,2-diphenylethane-1-one.
- 15. (New) The negative radiation-sensitive resin composition as claimed in claim 1, wherein (C) comprises benzyl dimethyl ketal.

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- 16. (New) The negative radiation-sensitive resin composition as claimed in claim 1, wherein (C) comprises benzyl- β -methoxyethyl acetal.
- 17. (New) The negative radiation-sensitive resin composition as claimed in claim 1, wherein (C) comprises 1-phenyl-1,2-propanedione-2-(o-ethoxycarbonyl) oxime.
- 18. (New) The negative radiation-sensitive resin composition as claimed in claim 1, wherein (C) comprises 2,2'-bis(2,4-dichlorophenyl)-4,5,4',5'-tetrapheyl-1-2'-bisimidazole.